

Notice of References Cited	Application/Control No. 10/583,705		Applicant(s)/Patent Under Reexamination TAKAI, SEIICHIRO	
	Examiner ATIF H. CHAUDRY		Art Unit 3753	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,372,340 A	02-1983	Rothrock, Elmer W.	137/576
*	B	US-5,624,204 A	04-1997	Dorsemaine, Jean-Pierre	405/52
*	C	US-6,382,237 B1	05-2002	Takai, Seiichiro	137/236.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1146176 A1	10-2001	European Patent	DEGAS, GERARD G	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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